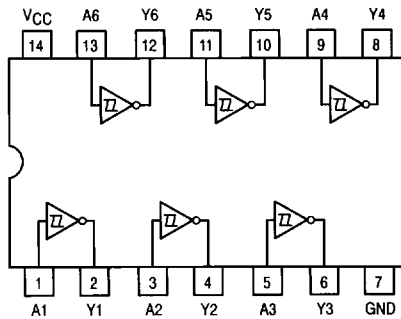




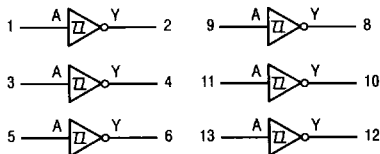
# Hex Inverter Schmitt Trigger

ELECTRICALLY TESTED PER:  
5962-8875201

LOGIC DIAGRAM



LOGIC SYMBOL



**Military 54F14**



AVAILABLE AS:

- 1) JAN: N/A
- 2) SMD: 5962-8875201
- 3) 883: 54F14/BXAJC

X = CASE OUTLINE AS FOLLOWS:  
PACKAGE: CERDIP: C  
CERFLAT: D  
LCC: 2

THE LETTER "M" APPEARS  
BEFORE THE / ON LCC.

PIN ASSIGNMENTS

FUNCT.	DIL 632-08	FLATS 717-04	LCC 756A-02	BURN-IN (COND. A)
A1	1	1	2	VCC
Y1	2	2	3	OPEN
A2	3	3	4	VCC
Y2	4	4	6	OPEN
A3	5	5	8	VCC
Y3	6	6	9	OPEN
GND	7	7	10	GND
Y4	8	8	12	OPEN
A4	9	9	13	VCC
Y5	10	10	14	OPEN
A5	11	11	16	VCC
Y6	12	12	18	OPEN
A6	13	13	19	VCC
VCC	14	14	20	VCC

BURN-IN CONDITIONS:  
VCC = 5.0 V MIN/6.0 V MAX

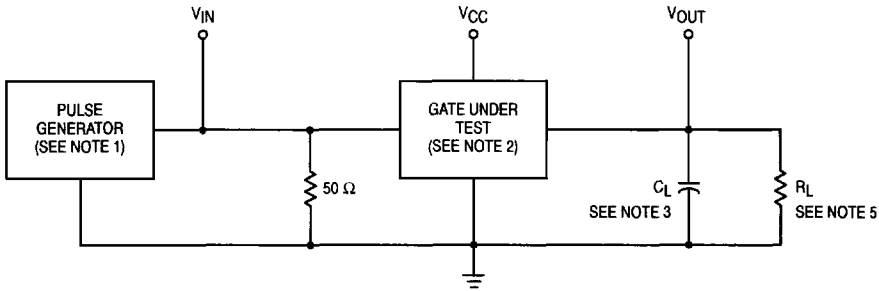
TRUTH TABLE

A	$\bar{Y}$
0	1
1	0

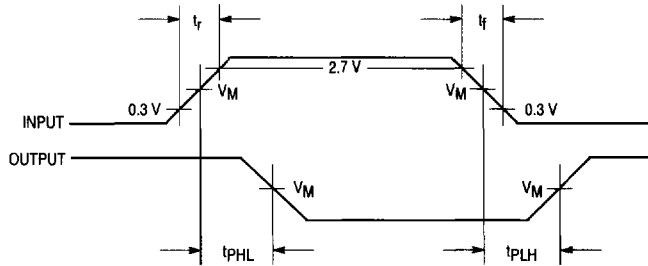
4

# 54F14

## AC TEST CIRCUIT

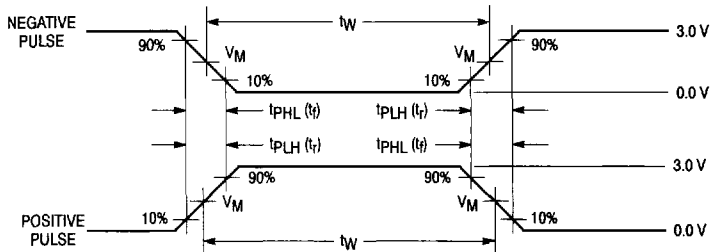


### WAVEFORM 1. FOR INVERTING OUTPUTS



NOTE: For all waveforms,  $V_M = 1.5\text{ V}$

### WAVEFORM 2



NOTE: For all waveforms,  $V_M = 1.5\text{ V}$

#### NOTES:

1. Pulse generator has the following characteristics:  
 $V_{IN} = 3.0\text{ V}$ ,  $t_{PLH} = t_{PHL} \leq 2.5\text{ ns}$ ,  $PRR = 1.0\text{ MHz}$ ,  $t_W = 500\text{ ns}$ ,  
and  $Z_{OUT} \approx 50\ \Omega$ .
2. Terminal conditions (pins not designated may be high  $\geq 1.5\text{ V}$ ,  
low  $\leq 1.1\text{ V}$ , or open).
3.  $C_L = 50\text{ pF} \pm 10\%$ , including scope probe, wiring and stray  
capacitance, without package in test fixture.
4. Voltage measurements are to be made with respect to network  
ground terminal.
5.  $R_L = 500\ \Omega \pm 5.0\%$ .
6.  $R_T \approx 50\ \Omega = Z_{OUT}$  of pulse generator.

Symbol	Parameter	Limits						Unit	Test Condition (Unless Otherwise Specified)
		+ 25°C		+ 125°C		- 55°C			
		Subgroup 1		Subgroup 2		Subgroup 3			
		Min	Max	Min	Max	Min	Max		
V <sub>OH1</sub>	Logical "1" Output Voltage	2.5		2.5		2.5		V	V <sub>CC</sub> = 4.5 V, I <sub>OH</sub> = -1.0 mA, V <sub>IL</sub> = 0.7 V.
V <sub>OH2</sub>	Logical "1" Output Voltage	2.5		2.5		2.5		V	V <sub>CC</sub> = 5.0 V, I <sub>OH</sub> = -1.0 mA, V <sub>IN</sub> = (See Note 1).
V <sub>OL1</sub>	Logical "0" Output Voltage		0.5		0.5		0.5	V	V <sub>CC</sub> = 4.5 V, I <sub>OL</sub> = 20 mA, V <sub>IH</sub> = 2.0 V.
V <sub>OL2</sub>	Logical "0" Output Voltage		0.5		0.5		0.5	V	V <sub>CC</sub> = 5.0 V, I <sub>OL</sub> = 20 mA, V <sub>IN</sub> = (See Note 2).
V <sub>IC</sub>	Input Clamping Voltage		-1.2					V	V <sub>CC</sub> = 4.5 V, I <sub>IN</sub> = -18 mA.
I <sub>IH</sub>	Logical "1" Input Current		20		20		20	μA	V <sub>CC</sub> = 5.5 V, V <sub>IN</sub> = 2.7 V, other inputs are open.
I <sub>IHH</sub>	Logical "1" Input Current		100		100		100	μA	V <sub>CC</sub> = 5.5 V, V <sub>IN</sub> = 7.0 V, other inputs are open.
I <sub>IL</sub>	Logical "0" Input Current	-0.03	-0.6	-0.03	-0.6	-0.03	-0.6	mA	V <sub>CC</sub> = 5.5 V, V <sub>IN</sub> = 0.5 V.
I <sub>OS</sub>	Output Short Circuit Current	-60	-150	-60	-150	-60	-150	mA	V <sub>CC</sub> = 5.5 V, V <sub>IN</sub> = GND, V <sub>OUT</sub> = GND.
I <sub>CCH</sub>	Power Supply Current		22		22		22	mA	V <sub>CC</sub> = 5.5 V, V <sub>IN</sub> = GND.
I <sub>CCL</sub>	Power Supply Current		32		32		32	mA	V <sub>CC</sub> = 5.5 V, V <sub>IN</sub> = 5.5 V.
V <sub>IH</sub>	Logical "1" Input Voltage	2.0		2.0		2.0		V	V <sub>CC</sub> = 4.5 V.
V <sub>IL</sub>	Logical "0" Input Voltage		0.5		0.5		0.5	V	V <sub>CC</sub> = 4.5 V.
	Functional Tests	Subgroup 7		Subgroup 8A		Subgroup 8B			per Truth Table with V <sub>CC</sub> = 4.5 V, (Repeat at), V <sub>CC</sub> = 5.5 V, V <sub>INL</sub> = 0.5 V, and V <sub>INH</sub> = 2.5 V.

Symbol	Parameter	Limits						Unit	Test Condition (Unless Otherwise Specified)
		+ 25°C		+ 125°C		- 55°C			
		Subgroup 9		Subgroup 10		Subgroup 11			
		Min	Max	Min	Max	Min	Max		
t <sub>PHL</sub>	Propagation Delay /Data-Output Output <u>High-Low</u>	3.5	7.5	3.0	10	3.0	10	ns	V <sub>CC</sub> = 5.0 V, C <sub>L</sub> = 50 pF, R <sub>L</sub> = 500 Ω.
t <sub>PLH</sub>	Propagation Delay /Data-Output Output <u>Low-High</u>	2.5	6.5	2.0	13	2.0	13	ns	V <sub>CC</sub> = 5.0 V, C <sub>L</sub> = 50 pF, R <sub>L</sub> = 500 Ω.

**NOTES:**

1. Momentary 0.5 V, then 1.5 V without overshoot during test. (0.5 V-1.5 V).
2. Momentary 2.0 V, then 1.1 V without undershoot during test. (2.0 V-1.1 V).